

Special Seminar (特別講演会);

EELS for Nanoscience

Prof. R.F. Egerton

Physics Department, University of Alberta, Canada

Editor of MICRON (Elsevier)

Author of several textbooks for TEM and EELS

The talk will focus on how to optimize electron energy-loss spectroscopy (EELS) for very thin TEM specimens, particularly considering the possibility of radiation damage. The advantages and limitations of using lower accelerating voltage will be discussed.

Venue: Collaborative Research Building 4F, Main Conference Room.

Date: Mar. 30th, 2010

Time: 11:00-12:00

Contact: Koji KIMOTO (ext. 4402)

場所: 共同研究棟 4階 大ゼミナール室

日時: 3月30日 11時—12時

連絡先: 木本浩司 (内線 4402)

